

**Search Notes**

Application/Control No.

10/523,141

Examiner

Maria Veronica D. Ewald

Applicant(s)/Patent under  
Reexamination

CHUN ET AL.

Art Unit

1722

**SEARCHED**

Class	Subclass	Date	Examiner
425	378.2	2/1/2007	MVE
425	464	2/1/2007	MVE
425	83.1	2/1/2007	MVE
425	174.8R	2/1/2007	MVE
425	DIG 217	2/1/2007	MVE

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Inventor search	2/1/2007	MVE
Also conducted backwards/forwards search on cited prior art using EAST	2/1/2007	MVE
Also conducted text search in EAST (see attached search history)	2/1/2007	MVE